

DS1644/DS1644PNonvolatile Timekeeping RAM

FEATURES

- Integrated NV SRAM, real time clock, crystal, powerfail control circuit and lithium energy source
- Clock registers are accessed identical to the static RAM. These registers are resident in the eight top RAM locations.
- Totally nonvolatile with over 10 years of operation in the absence of power
- Access time of 120 ns and 150 ns
- BCD coded year, month, date, day, hours, minutes, and seconds with leap year compensation valid up to 2100
- Power-fail write protection allows for ±10% V_{CC} power supply tolerance
- DS1644 only (DIP Module)
 - Upward compatible with the DS1643 Timekeeping RAM to achieve higher RAM density
 - Standard JEDEC Byte-wide 32K x 8 static RAM pinout
- DS1644P only (PowerCap Module Board)
 - Surface mountable package for direct connection to PowerCap containing battery and crystal
 - Replaceable battery (PowerCap)
 - Power-fail Output
 - Pin for pin compatible with other densities of DS164XP Timekeeping RAM

ORDERING INFORMATION

DS1644–XXX 28–pin DIP module

-120 120 ns access
-150 150 ns access

*DS1644P-XXX 34-pin PowerCap Module Board

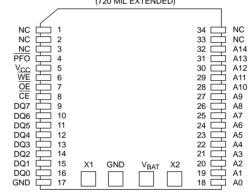
→ -120 120 ns access -150 150 ns access

*DS9034PCX (Power Cap) Required; must be ordered separately

PIN ASSIGNMENT

A14	1	28	VCC
A12	2	27	WE
A7	3	26	A13
A6	4	25	A8
A5	5	24	A9
A4	■ 6	23	A11
A3	7	22	OE
A2	■ 8	21 📗	A10
A1	9	20	CE
A0	10	19	DQ7
DQ0	1 1	18	DQ6
DQ1	12	17	DQ5
DQ2	13	16	DQ4
GND	1 4	15	DQ3

28-PIN ENCAPSULATED PACKAGE (720 MIL EXTENDED)



34-PIN POWERCAP MODULE BOARD (USES DS9034PCX POWERCAP)

PIN DESCRIPTION

 A0-A14
 — Address Input

 CE
 — Chip Enable

 OE
 — Output Enable

 WE
 — Write Enable

 V_{CC}
 — +5 Volts

 GND
 — Ground

 DQ0-DQ7
 — Data Input/Output

NC – No Connection

PFO – Power–fail Output (DS1644P only)

X1, X2 – Crystal Connection V_{BAT} – Battery Connection

DESCRIPTION

The DS1644 is a 32K x 8 nonvolatile static RAM with a full function real time clock which are both accessible in a Byte-wide format. The nonvolatile timekeeping RAM is function equivalent to any JEDEC standard 32K x 8 SRAM. The device can also be easily substituted for ROM, EPROM and EEPROM, providing read/write nonvolatility and the addition of the real time clock function. The real time clock information resides in the eight uppermost RAM locations. The RTC registers contain year, month, date, day, hours, minutes, and seconds data in 24 hour BCD format. Corrections for the day of the month and leap year are made automatically. The RTC clock registers are double buffered to avoid access of incorrect data that can occur during clock update cycles. The double buffered system also prevents time loss as the timekeeping countdown continues unabated by access to time register data. The DS1644 also contains its own power-fail circuitry which deselects the device when the V_{CC} supply is in an out-of-tolerance condition. This feature prevents loss of data from unpredictable system operation brought on by low V_{CC} as errant access and update cycles are avoided.

PACKAGES

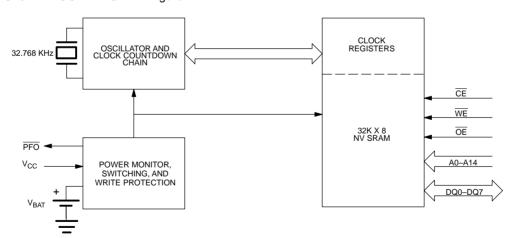
The DS1644 is available in two packages (28–pin DIP and 34–pin PowerCap module). The 28–pin DIP style module integrated the crystal, lithium energy source, and silicon all in one package. The 34–pin PowerCap Module Board is designed with contacts for connection to a separate PowerCap (DS9034PCX) that contains

the crystal and battery. This design allows the Power-Cap to be mounted on top of the DS1644P after the completion of the surface mount process. Mounting the Power-Cap after the surface mount process prevents damage to the crystal and battery due to the high temperatures required for solder reflow. The Power-Cap is keyed to prevent reverse insertion. The Power-Cap Module Board and Power-Cap are ordered separately and shipped in seperate containers. The part number for the Power-Cap is DS9034PCX.

CLOCK OPERATIONS – READING THE CLOCK

While the double buffered register structure reduces the chance of reading incorrect data, internal updates to the DS1644 clock registers should be halted before clock data is read to prevent reading of data in transition. However, halting the internal clock register updating process does not affect clock accuracy. Updating is halted when a one is written into the read bit, the seventh most significant bit in the control register. As long as a one remains in that position, updating is halted. After a halt is issued, the registers reflect the count, that is day, date, and time that was current at the moment the halt command was issued. However, the internal clock registers of the double buffered system continue to update so that the clock accuracy is not affected by the access of data. All of the DS1644 registers are updated simultaneously after the clock status is reset. Updating is within a second after the read bit is written to zero.

DS1644 BLOCK DIAGRAM Figure 1



DS1644 TRUTH TABLE Table 1

V _{CC}	CE	OE	WE	MODE	DQ	POWER
	V _{IH}	Х	Х	DESELECT	HIGH–Z	STANDBY
	Х	Х	Х	DESELECT	HIGH–Z	STANDBY
5 VOLTS ± 10%	V _{IL}	Х	V _{IL}	WRITE	DATA IN	ACTIVE
	V _{IL}	V _{IL}	V _{IH}	READ	DATA OUT	ACTIVE
	V _{IL}	V _{IH}	V _{IH}	READ	HIGH–Z	ACTIVE
<4.5 VOLTS >V _{BAT}	Х	Х	Х	DESELECT	HIGH–Z	CMOS STANDBY
<v<sub>BAT</v<sub>	Х	Х	Х	DESELECT	DESELECT HIGH-Z	

SETTING THE CLOCK

The eighth bit of the control register is the write bit. Setting the write bit to a one, like the read bit, halts updates to the DS1644 registers. The user can then load them with the correct day, date and time data in 24 hour BCD format. Resetting the write bit to a zero then transfers those values to the actual clock counters and allows normal operation to resume.

STOPPING AND STARTING THE CLOCK OSCILLATOR

The clock oscillator may be stopped at any time. To increase the shelf life, the oscillator can be turned off to minimize current drain from the battery. The $\overline{\text{OSC}}$ bit is the MSB for the seconds registers. Setting it to a one stops the oscillator.

FREQUENCY TEST BIT

Bit 6 of the day byte is the frequency test bit. When the frequency test bit is set to logic "1" and the oscillator is running, the LSB of the seconds register will toggle at

512 Hz. When the seconds register is being read, the DQ0 line will toggle at the 512 Hz frequency as long as conditions for access remain valid (i.e., $\overline{\text{CE}}$ low, $\overline{\text{OE}}$ low, and address for seconds register remain valid and stable).

CLOCK ACCURACY (DIP MODULE)

The DS1644 is guaranteed to keep time accuracy to within ± 1 minute per month at 25°C. The clock is calibrated at the factory by Dallas Semiconductor using special calibration nonvolatile tuning elements. The DS1644 does not require additional calibration, and temperature deviations will have a negligible effect in most applications. For this reason, methods of field clock calibration are not available and not necessary.

CLOCK ACCURACY (POWERCAP MODULE)

The DS1644P and DS9034PCX are each individually tested for accuracy. Once mounted together, the module is guaranteed to keep time accuracy to within ± 1.53 minutes per month (35 ppm) at 25°C.

DS1644 REGISTER MAP - BANK1 Table 2

ADDDECC		DATA								1011
ADDRESS	B ₇	В6	B ₅	В4	В3	B ₂	B ₁	B ₀	FUNCT	ON
7FFF	-	-	-	_	-	-	-	-	YEAR	00–99
7FFE	Х	Х	Х	_	-	-	-	-	MONTH	01–12
7FFD	Х	Х	-	_	-	-	-	-	DATE	01–31
7FFC	Х	FT	Χ	Χ	Χ	-	-	-	DAY	01–07
7FFB	Х	Х	-	_	-	-	-	-	HOUR	00–23
7FFA	Х	-	-		-	-	-	-	MINUTES	00–59
7FF9	OSC	-	-	_	-	-	-	-	SECONDS	00–59
7FF8	W	R	Х	Х	Х	Х	Х	Х	CONTROL	Α

OSC = STOP BIT W = WRITE BIT R = READ BIT X = UNUSED FT = FREQUENCY TEST

NOTE:

All indicated "X" bits are not dedicated to any particular function and can be used as normal RAM bits.

RETRIEVING DATA FROM RAM OR CLOCK

The DS1644 is in the read mode whenever $\overline{\text{WE}}$ (write enable) is high, and $\overline{\text{CE}}$ (chip enable) is low. The device architecture allows ripple-through access to any of the address locations in the NV SRAM. Valid data will be available at the DQ pins within t_{AA} after the last address input is stable, providing that the $\overline{\text{CE}}$ and $\overline{\text{OE}}$ access times and states are satisfied. If $\overline{\text{CE}}$ or $\overline{\text{OE}}$ access times are not met, valid data will be available at the latter of chip enable access ($t_{\mbox{\footnotesize{CEA}}}$) or at output enable access time (t_{OEA}). The state of the data input/output pins (DQ) is controlled by \overline{CE} and \overline{OE} . If the outputs are activated before t_{AA} , the data lines are driven to an intermediate state until $t_{\mbox{\scriptsize AA}}$. If the address inputs are changed while CE and OE remain valid, output data will remain valid for output data hold time (t_{OH}) but will then go indeterminate until the next address access.

WRITING DATA TO RAM OR CLOCK

The DS1644 is in the write mode whenever \overline{WE} and \overline{CE} are in their active state. The start of a write is referenced to the latter occurring high to low transition of \overline{WE} or \overline{CE} . The addresses must be held valid throughout the cycle. \overline{CE} or \overline{WE} must return inactive for a minimum of t_{WR} prior to the initiation of another read or write cycle. Data in must be valid t_{DS} prior to the end of write and remain valid for t_{DH} afterward. In a typical application, the \overline{OE} signal will be high during a write cycle. However, \overline{OE} can be active provided that care is taken with the data bus to avoid bus contention. If \overline{OE} is low prior to \overline{WE} transitioning low the data bus can become active with read data defined by the address inputs. A low transition on \overline{WE} will then disable the outputs t_{WEZ} after \overline{WE} goes active.

DATA RETENTION MODE

When V_{CC} is within nominal limits ($V_{CC} > 4.5$ volts) the DS1644 can be accessed as described above with read or write cycles. However, when V_{CC} is below the power–fail point V_{PF} (point at which write protection occurs) the internal clock registers and RAM are blocked from access. This is accomplished internally by inhibiting access via the \overline{CE} signal. At this time the power–fail output signal (\overline{PFO}) will be driven active low and will remain active until V_{CC} returns to nominal levels. When V_{CC} falls below the level of the internal battery supply, power input is switched from the V_{CC} pin to the internal battery and clock activity, RAM, and clock data are maintained from the battery until V_{CC} is returned to nominal level.

BATTERY LONGEVITY

The DS1644 has a lithium power source that is designed to provide energy for clock activity, and clock and

RAM data retention when the V_{CC} supply is not present. The capability of this power supply is sufficient to power the DS1644 continuously for the life of the equipment in which it is installed. For specification purposes, the life expectancy is 10 years at 25°C with the internal clock oscillator running in the absence of V_{CC} power. The DS1644 is shipped from Dallas Semiconductor with the clock oscillator turned off, so the expected life should be considered to start from the time the clock oscillator is first turned on. Actual life expectancy of the DS1644 will be much longer than 10 years since no lithium battery energy is consumed when V_{CC} is present. In fact, in most applications, the life expectancy of the DS1644 will be approximately equal to the shelf life (expected useful life of the lithium battery with no load attached) of the lithium battery which may prove to be as long as 20 years.

ABSOLUTE MAXIMUM RATINGS* Voltage on Any Pin Relative to Ground -0.3V to +7.0V Operating Temperature Storage Temperature 0°C to 70°C -20°C to +70°C

Soldering Temperature 260°C for 10 seconds (See Note 7)

RECOMMENDED DC OPERATING CONDITIONS

(0°C to 70°C)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Supply Voltage	V _{CC}	4.5	5.0	5.5	V	1
Logic 1 Voltage All Inputs	V _{IH}	2.2		V _{CC} +0.3	V	
Logic 0 Voltage All Inputs	V _{IL}	-0.3		0.8	V	

DC ELECTRICAL CHARACTERISTICS

 $(0^{\circ}C \le t_A \le 70^{\circ}C; V_{CC}=5.0V \pm 10\%)$

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Average V _{CC} Power Supply Current	I _{CC1}			75	mA	3
TTL Standby Current (CE = V _{IH})	I _{CC2}			6	mA	3
CMOS Standby Current (CE=V _{CC} -0.2V)	I _{CC3}			4.0	mA	3
Input Leakage Current (any input)	I _{IL}	-1		+1	μΑ	
Output Leakage Current	I _{OL}	-1		+1	μΑ	
Output Logic 1 Voltage (I _{OUT} = -1.0 mA)	V _{OH}	2.4			V	
Output Logic 0 Voltage (I _{OUT} = +2.1 mA)	V _{OL}			0.4	V	
Write Protection Voltage	V _{PF}	4.0	4.25	4.5	V	

^{*} This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

AC ELECTRICAL CHARACTERISTICS

(0°C to 70°C; V_{CC} = 5.0V ± 10%)

DADAMETED	OVMDOL	DS164	14–120	DS164	14–150	LINUTO	NOTES
PARAMETER	SYMBOL	MIN	MAX	MIN	MAX	UNITS	NOTES
Read Cycle Time	t _{RC}	120		150		ns	
Address Access Time	t _{AA}		120		150	ns	
CE Access Time	t _{CEA}		120		150	ns	
CE Data Off Time	t _{CEZ}		40		50	ns	
Output Enable Access Time	t _{OEA}		100		120	ns	
Output Enable Data Off Time	t _{OEZ}		40		50	ns	
Output Enable to DQ Low-Z	t _{OEL}	5		5		ns	
CE to DQ Low–Z	t _{CEL}	5		5		ns	
Output Hold from Address	t _{OH}	5		5		ns	
Write Cycle Time	t _{WC}	120		150		ns	
Address Setup Time	t _{AS}	0		0		ns	
CE Pulse Width	t _{CEW}	100		120		ns	
Address Hold from End of Write	t _{AH1} t _{AH2}	5 30		5 30		ns ns	5 6
Write Pulse Width	t _{WEW}	120		150		ns	
WE Data Off Time	t _{WEZ}		40		50	ns	
WE or CE Inactive Time	t _{WR}	10		10		ns	
Data Setup Time	t _{DS}	85		110		ns	
Data Hold Time High	t _{DH1}	0 15		0 15		ns ns	5 6

AC TEST CONDITIONS

Input Levels: 0V to 3V Transition Times: 5 ns

CAPACITANCE

 $(t_A = 25^{\circ}C)$

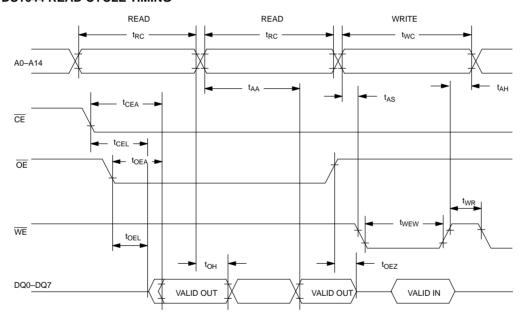
PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Capacitance on all pins (except DQ)	C _I			7	pF	
Capacitance on DQ pins	C _{DQ}			10	pF	

AC ELECTRICAL CHARACTERISTICS (POWER-UP/DOWN TIMING)

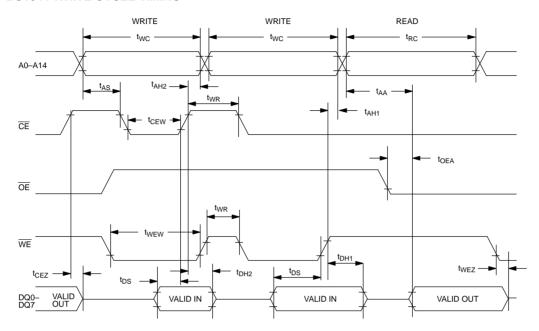
(0°C to 70°C)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
CE or WE at V _{IH} before Power Down	t _{PD}	0			μs	
$\ensuremath{V_{PF}}$ (Max) to $\ensuremath{V_{PF}}$ (Min) $\ensuremath{V_{CC}}$ Fall Time	t _F	300			μs	
V _{PF} (Min) to V _{SO} V _{CC} Fall Time	t _{FB}	10			μs	
V _{SO} to V _{PF} (Min) V _{CC} Rise Time	t _{RB}	1			μs	
$\ensuremath{V_{PF}}$ (Min) to $\ensuremath{V_{PF}}$ (Max) $\ensuremath{V_{CC}}$ Rise Time	t _R	0			μs	
Power-Up	t _{REC}	15	25	35	ms	
Expected Data Retention Time (Oscillator On)	t _{DR}	10			years	4

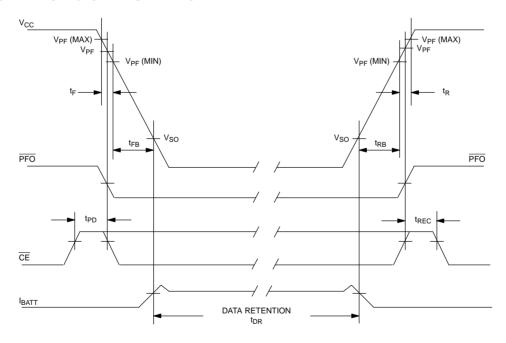
DS1644 READ CYCLE TIMING



DS1644 WRITE CYCLE TIMING



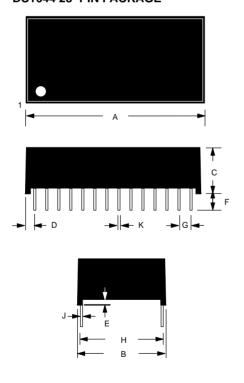
POWER-DOWN/POWER-UP TIMING



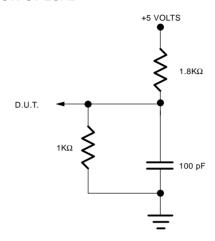
NOTES:

- 1. All voltages are referenced to ground.
- 2. Typical values are at 25°C and nominal supplies.
- 3. Outputs are open.
- 4. Data retention time is at 25°C and is calculated from the date code on the device package. The date code XXYY is the year followed by the week of the year in which the device was manufactured. For example, 9225, would mean the 25th week of 1992.
- 5. t_{AH1} , t_{DH1} are measured from \overline{WE} going high.
- 6. t_{AH2} , t_{DH2} are measured from \overline{CE} going high.
- 7. Real–Time Clock Modules can be successfully processed through conventional wave–soldering techniques as long as temperature exposure to the lithium energy source contained within does not exceed +85°C. Post solder cleaning with water washing techniques is acceptable, provided that ultrasonic vibration is not used to prevent damage to the crystal.

DS1644 28-PIN PACKAGE

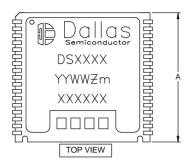


OUTPUT LOAD

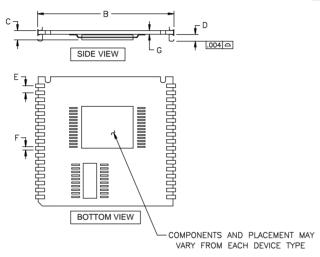


PKG	28–	PIN
DIM	MIN	MAX
A IN.	1.470	1.490
MM	37.34	37.85
B IN.	0.715	0.740
MM	18.16	18.80
C IN.	0.335	0.365
MM	8.51	9.27
D IN.	0.075	0.105
MM	1.91	2.67
E IN.	0.015	0.030
MM	0.38	0.76
F IN.	0.140	0.180
MM	3.56	4.57
G IN.	0.090	0.110
MM	2.29	2.79
H IN.	0.590	0.630
MM	14.99	16.00
J IN.	0.010	0.018
MM	0.25	0.45
K IN.	0.015	0.025
MM	0.38	0.64

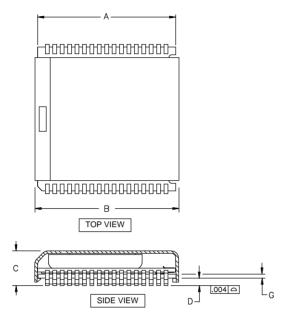
DS1644P



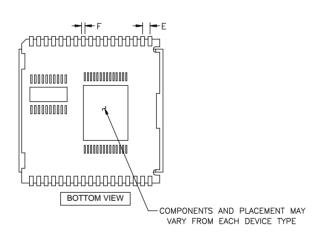
PKG	INCHES					
DIM	MIN	NOM	MAX			
Α	0.920	0.925	0.930			
В	0.980	0.985	0.990			
С	-	-	0.080			
D	0.052	0.055	0.058			
Е	0.048	0.050	0.052			
F	0.015	0.020	0.025			
G	0.025	0.027	0.030			



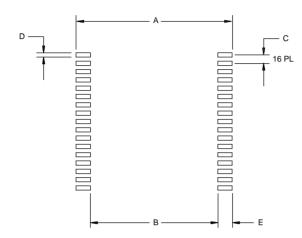
DS1644P WITH DS9034PCX ATTACHED



PKG	INCHES					
DIM	MIN	NOM	MAX			
Α	0.920	0.925	0.930			
В	0.955	0.960	0.965			
С	0.240	0.245	0.250			
D	0.052	0.055	0.058			
Е	0.048	0.050	0.052			
F	0.015	0.020	0.025			
G	0.020	0.025	0.030			



RECOMMENDED POWERCAP MODULE LAND PATTERN



	INCHES					
PKG DIM	MIN	NOM	MAX			
Α	-	1.050	-			
В	-	0.826	-			
С	=	0.050	-			
D	_	0.030	_			
Е	-	0.112	-			